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| <ul> <li>Standard '245-Type Pinout</li> <li>5-Ω Switch Connection Between Two Ports</li> </ul>   | DBQ, DGV, DW, OR PW PACKAGE<br>(TOP VIEW)                              |  |  |  |  |
|--|--|--|--|--|--|
| <ul> <li>Isolation Under Power-Off Conditions</li> </ul>   |  |  |  |  |  |
| <ul> <li>ESD Protection Exceeds 2000 V Per<br/>MIL-STD-883, Method 3015; Exceeds 200 V<br/>Using Machine Model (C = 200 pF, R = 0)</li> </ul>  | A1 [ 2 19 ] OE<br>A2 [ 3 18 ] B1<br>A3 [ 4 17 ] B2                     |  |  |  |  |
| <ul> <li>Latch-Up Performance Exceeds 250 mA Per<br/>JESD 17</li> </ul>  | A4 [ 5 16 ] B3<br>A5 [ 6 15 ] B4                                       |  |  |  |  |
| <ul> <li>Package Options Include Shrink<br/>Small-Outline (DBQ), Thin Very<br/>Small-Outline (DGV), Small-Outline (DW),<br/>and Thin Shrink Small-Outline (PW)<br/>Packages</li> </ul> | A6 [ 7 14 ] B5<br>A7 [ 8 13 ] B6<br>A8 [ 9 12 ] B7<br>GND [ 10 11 ] B8 |  |  |  |  |
| i donagos  | NC – No internal connection  |  |  |  |  |

### description

The SN74CBTLV3245A provides eight bits of high-speed bus switching in a standard '245 device pinout. The low on-state resistance of the switch allows connections to be made with minimal propagation delay.

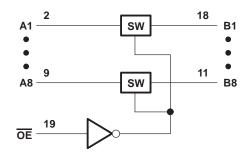
The device is organized as one 8-bit switch. When output enable ( $\overline{OE}$ ) is low, the 8-bit bus switch is on and A port is connected to B port. When  $\overline{OE}$  is high, the switch is open and the high-impedance state exists between the two ports.

To ensure the high-impedance state during power up or power down,  $\overline{OE}$  should be tied to V<sub>CC</sub> through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

The SN74CBTLV3245A is characterized for operation from –40°C to 85°C.

| FUNCTION TABLE       |                 |  |  |  |
|----------------------|-----------------|--|--|--|
| INPUT<br>OE FUNCTION |                 |  |  |  |
| L                    | A port = B port |  |  |  |
| Н                    | Disconnect      |  |  |  |

### logic diagram (positive logic)





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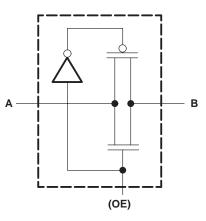
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### simplified schematic, each FET switch



## absolute maximum ratings over operating free-air temperature range (unless otherwise noted)<sup>†</sup>

| Supply voltage range, V <sub>CC</sub><br>Input voltage range, V <sub>I</sub> (see Note 1)<br>Continuous channel current |               | –0.5 V to 4.6 V |
|---|---------------|-----------------|
| Input clamp current, I <sub>IK</sub> (V <sub>I/O</sub> < 0)   |               |                 |
| Package thermal impedance, $\theta_{JA}$ (see Note 2)   | : DBQ package |                 |
|   | DGV package   | 92°C/W          |
|   | DW package    | 58°C/W          |
|   | PW package    | 83°C/W          |
| Storage temperature range, T <sub>stg</sub>   |               | –65°C to 150°C  |

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

2. The package thermal impedance is calculated in accordance with JESD 51.

## recommended operating conditions (see Note 3)

|                                |  |  | MIN | MAX | UNIT |
|--------------------------------|--|--|-----|-----|------|
| V <sub>CC</sub> Supply voltage |  |  | 2.3 | 3.6 | V    |
| V <sub>IH</sub> H              | Lisk lovel control input veltage           | $V_{CC}$ = 2.3 V to 2.7 V                  | 1.7 |     | V    |
|                                | High-level control input voltage           | V <sub>CC</sub> = 2.7 V to 3.6 V           | 2   |     | v    |
| V <sub>IL</sub> Low-le         | $V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$ |  |     | 0.7 | V    |
|                                | r-level control input voltage              | $V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$ |     | 0.8 | v    |
| Т <sub>А</sub>                 | Operating free-air temperature             |  | -40 | 85  | °C   |

NOTE 3: All unused control inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.



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| PA                         | RAMETER        |  | TEST CONDITION                  | ONS                             | MIN | TYP† | MAX  | UNIT |
|----------------------------|----------------|--|---------------------------------|---------------------------------|-----|------|------|------|
| Maria                      | Control inputs |  | 10 m A                          |                                 |     |      | -1.2 | M    |
| VIK                        | Data inputs    | V <sub>CC</sub> = 3 V,                                     | lj = –18 mA                     |                                 |     |      | -0.8 | V    |
| l                          | -              | V <sub>CC</sub> = 3.6 V,                                   | $V_I = V_{CC}$ or GND           |                                 |     |      | ±60  | μΑ   |
| loff                       |                | $V_{CC} = 0,$  | $V_{I}$ or $V_{O}$ = 0 to 3.6 V |                                 |     |      | 40   | μΑ   |
| ICC                        |                | V <sub>CC</sub> = 3.6 V,                                   | IO = 0,                         | $V_I = V_{CC} \text{ or } GND$  |     |      | 20   | μΑ   |
| $\Delta I_{CC}^{\ddagger}$ | Control inputs | V <sub>CC</sub> = 3.6 V,                                   | One input at 3 V,               | Other inputs at $V_{CC}$ or GND |     |      | 300  | μΑ   |
| Ci                         | Control inputs | V <sub>I</sub> = 3 V or 0                                  |                                 |                                 |     | 4    |      | pF   |
| C <sub>io(OF</sub>         | F)             | V <sub>O</sub> = 3 V or 0,                                 | $\overline{OE} = V_{CC}$        |                                 |     | 9    |      | pF   |
|                            |                |  | $V_{\parallel} = 0$             | I <sub>O</sub> = 64 mA          |     | 5    | 8    |      |
| r <sub>on</sub> §          |                | V <sub>CC</sub> = 2.3 V,<br>TYP at V <sub>CC</sub> = 2.5 V | vj=0                            | I <sub>O</sub> = 24 mA          |     | 5    | 8    | Ω    |
|                            |                |  | V <sub>I</sub> = 1.7 V,         | I <sub>O</sub> = 15 mA          |     | 27   | 40   |      |
|                            |                | V <sub>CC</sub> = 3 V                                      | V <sub>1</sub> = 0              | I <sub>O</sub> = 64 mA          |     | 5    | 7    |      |
|                            |                |  |                                 | I <sub>O</sub> = 24 mA          |     | 5    | 7    |      |
|                            |                |  | V <sub>I</sub> = 2.4 V,         | I <sub>O</sub> = 15 mA          |     | 10   | 15   |      |

# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

<sup>†</sup> All typical values are at V<sub>CC</sub> = 3.3 V (unless otherwise noted), T<sub>A</sub> = 25°C.

<sup>‡</sup>This is the increase in supply current for each input that is at the specified voltage level rather than V<sub>CC</sub> or GND.

§ Measured by the voltage drop between the A and B terminals at the indicated current through the switch. On-state resistance is determined by the lower of the voltages of the two (A or B) terminals.

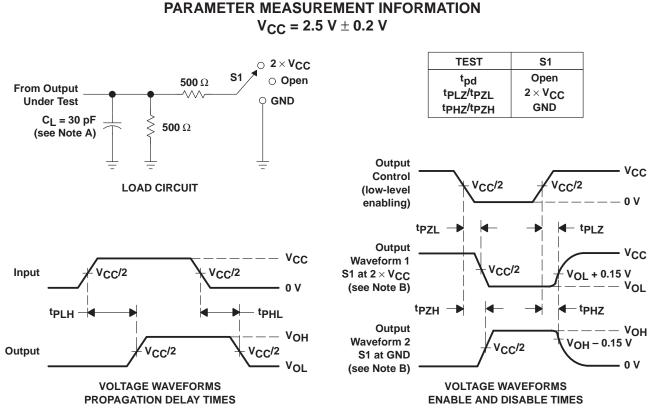
# switching characteristics over recommended operating free-air temperature range (unless otherwise noted) (see Figures 1 and 2)

| PARAMETER         | FROM<br>(INPUT) | TO<br>(OUTPUT) | V <sub>CC</sub> = 2.5 V<br>± 0.2 V |      | V <sub>CC</sub> = 3.3 V<br>± 0.3 V |      | UNIT |
|-------------------|-----------------|----------------|------------------------------------|------|------------------------------------|------|------|
|                   |                 |                | MIN                                | MAX  | MIN                                | MAX  |      |
| t <sub>pd</sub> ¶ | A or B          | B or A         |                                    | 0.15 |                                    | 0.25 | ns   |
| ten               | OE              | A or B         | 1                                  | 6    | 1                                  | 4.7  | ns   |
| <sup>t</sup> dis  | OE              | A or B         | 1                                  | 6.1  | 1                                  | 6.4  | ns   |

The propagation delay is the calculated RC time constant of the typical on-state resistance of the switch and the specified load capacitance when driven by an ideal voltage source (zero output impedance).



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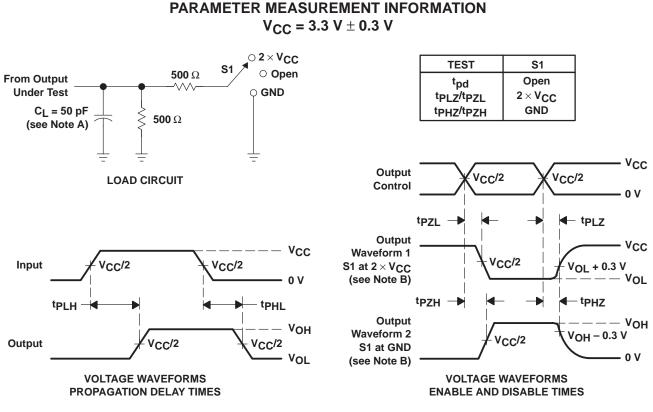
NOTES: A. CL includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
   C. All input pulses are supplied by generators having the following characteristics: PRR ≤ 10 MHz, Z<sub>O</sub> = 50 Ω, t<sub>f</sub> ≤ 2 ns, t<sub>f</sub> ≤ 2 ns.
- D. The outputs are measured one at a time with one transition per measurement.
- E.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .
- F.  $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{en}$ .
- G.  $t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$ .

## Figure 1. Load Circuit and Voltage Waveforms



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NOTES: A. CL includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz, Z<sub>O</sub> = 50  $\Omega$ , t<sub>f</sub>  $\leq$  2 ns, t<sub>f</sub>  $\leq$  2 ns.
- D. The outputs are measured one at a time with one transition per measurement.
- E. tpLZ and tpHZ are the same as tdis.
- F.  $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{en}$ .
- G. tPLH and tPHL are the same as tpd.

#### Figure 2. Load Circuit and Voltage Waveforms



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